

54F/74F257A Quad 2-Input Multiplexer with TRI-STATE® Outputs

General Description

The 'F257A is a quad 2-input multiplexer with TRI-STATE outputs. Four bits of data from two sources can be selected using a Common Data Select input. The four outputs present the selected data in true (non-inverted) form. The outputs may be switched to a high impedance state with a HIGH on the common Output Enable (\overline{OE}) input, allowing the outputs to interface directly with bus-oriented systems.

Features

- Multiplexer expansion by tying outputs together
- Non-inverting TRI-STATE outputs
- Input clamp diodes limit high-speed termination effects
- Guaranteed 4000V minimum ESD protection

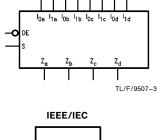
Commercial	Military	Package Number	Package Description		
74F257APC		N16E	16-Lead (0.300" Wide) Molded Dual-In-Line		
	54F257ADM (Note 2)	J16A	16-Lead Ceramic Dual-In-Line		
74F257ASC (Note 1)		M16A	16-Lead (0.150" Wide) Molded Small Outline, JEDEC		
74F257ASJ (Note 1)		M16D	16-Lead (0.300" Wide) Molded Small Outline, EIAJ		
	54F257AFM (Note 2)	W16A	16-Lead Cerpack		
	54F257ALL (Note 2)	E20A	20-Lead Ceramic Leadless Chip Carrier, Type C		

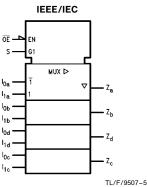
Note 1: Devices also available in 13" reel. Use suffix = SCX and SJX.

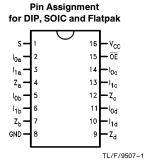
Note 2: Military grade device with environmental and burn-in processing. Use suffix = DMQB, FMQB and LMQB.

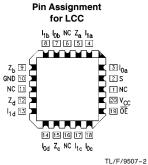
Logic Symbols

Connection Diagrams









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RRD-B30M75/Printed in U. S. A.

Unit Loading/Fan Out

		54F/74F			
Pin Names	Description	U.L. HIGH/LOW	Input I _{IH} /I _{IL} Output I _{OH} /I _{OL}		
S	Common Data Select Input	1.0/1.0	20 μA/ - 0.6 mA		
ŌĒ	TRI-STATE Output Enable Input (Active LOW)	1.0/1.0	20 μA/ - 0.6 mA		
I _{0a} -I _{0d}	Data Inputs from Source 0	1.0/1.0	20 μA/ - 0.6 mA		
I _{1a} -I _{1d}	Data Inputs from Source 1	1.0/1.0	20 μA/ - 0.6 mA		
$Z_a - Z_d$	TRI-STATE Multiplexer Outputs	150/40 (33.3)	-3 mA/24 mA (20 mA)		

Functional Description

The 'F257A is a quad 2-input multiplexer with TRI-STATE outputs. It selects four bits of data from two sources under control of a Common Data Select input. When the Select input is LOW, the $\ensuremath{\text{I}_{0x}}$ inputs are selected and when Select is HIGH, the I_{1x} inputs are selected. The data on the selected inputs appears at the outputs in true (non-inverted) form. The device is the logic implementation of a 4-pole, 2-position switch where the position of the switch is determined by the logic levels supplied to the Select input. The logic equation for the outputs is shown below:

$$\mathsf{Z}_{\mathsf{n}} = \overline{\mathsf{OE}} \bullet (\mathsf{I}_{\mathsf{n}} \bullet \mathsf{S} + \mathsf{I}_{\mathsf{on}} \bullet \overline{\mathsf{S}})$$

When the Output Enable input (\overline{OE}) is HIGH, the outputs are forced to a high impedance OFF state. If the outputs are tied together, all but one device must be in the high impedance state to avoid high currents that would exceed the maximum ratings. Designers should ensure the Output Enable signals to TRI-STATE devices whose outputs are tied together are designed so there is no overlap.

Truth Table

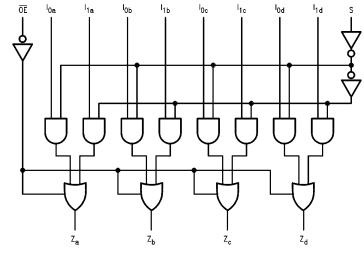
Output Enable	Select Input	Data Inputs		Output
ŌĒ	S	I ₀	I ₁	Z
Н	Х	Х	Х	Z
L	Н	X	L	L
L	Н	X	Н	Н
L	L	L	X	L
L	L	Н	Χ	Н

H = HIGH Voltage Level L = LOW Voltage Level

X = Immaterial

Z = High Impedance

Logic Diagram



TL/F/9507-4

Please note that this diagram is provided only for the understanding of logic operations and should not be used to estimate propagation delays.

Absolute Maximum Ratings (Note 1)

If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/Distributors for availability and specifications.

 $\begin{array}{lll} \text{Storage Temperature} & -65^{\circ}\text{C to} + 150^{\circ}\text{C} \\ \text{Ambient Temperature under Bias} & -55^{\circ}\text{C to} + 125^{\circ}\text{C} \\ \text{Junction Temperature under Bias} & -55^{\circ}\text{C to} + 175^{\circ}\text{C} \\ \text{Plastic} & -55^{\circ}\text{C to} + 150^{\circ}\text{C} \\ \end{array}$

V_{CC} Pin Potential to

 Ground Pin
 -0.5V to +7.0V

 Input Voltage (Note 2)
 -0.5V to +7.0V

 Input Current (Note 2)
 -30 mA to +5.0 mA

Voltage Applied to Output

in HIGH State (with $V_{CC} = 0V$)

 $\begin{array}{ll} \text{Standard Output} & -0.5 \text{V to V}_{\text{CC}} \\ \text{TRI-STATE Output} & -0.5 \text{V to } +5.5 \text{V} \end{array}$

Current Applied to Output in LOW State (Max)

twice the rated I_{OL} (mA)

ESD Last Passing Voltage (Min) 4000V

Note 1: Absolute maximum ratings are values beyond which the device may be damaged or have its useful life impaired. Functional operation under these conditions is not implied.

Note 2: Either voltage limit or current limit is sufficient to protect inputs.

Recommended Operating Conditions

Free Air Ambient Temperature

Military $-55^{\circ}\text{C to} + 125^{\circ}\text{C}$ Commercial $0^{\circ}\text{C to} + 70^{\circ}\text{C}$

Supply Voltage

Military +4.5V to +5.5V Commercial +4.5V to +5.5V

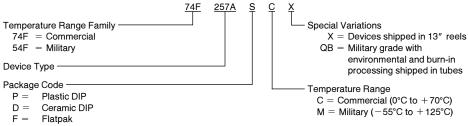
DC Electrical Characteristics

Symbol	Parameter		54F/74F			Units	Vcc	Conditions	
Syllibol	raiaille	tei	Min	Тур	Max	Units	VCC	Conditions	
V _{IH}	Input HIGH Voltage		2.0			V		Recognized as a HIGH Signal	
V _{IL}	Input LOW Voltage				0.8	V		Recognized as a LOW Signal	
V _{CD}	Input Clamp Diode Voltage				-1.2	V	Min	$I_{\text{IN}} = -18 \text{mA}$	
V _{OH}	Output HIGH Voltage	54F 10% V _{CC} 54F 10% V _{CC} 74F 10% V _{CC} 74F 10% V _{CC} 74F 5% V _{CC} 74F 5% V _{CC}	2.5 2.4 2.5 2.4 2.7 2.7			V	Min	$\begin{split} I_{OH} &= -1 \text{ mA} \\ I_{OH} &= -3 \text{ mA} \\ I_{OH} &= -1 \text{ mA} \\ I_{OH} &= -3 \text{ mA} \\ I_{OH} &= -1 \text{ mA} \\ I_{OH} &= -3 \text{ mA} \\ I_{OH} &= -3 \text{ mA} \end{split}$	
V _{OL}	Output LOW Voltage	54F 10% V _{CC} 74F 10% V _{CC}			0.5 0.5	٧	Min	I _{OL} = 20 mA I _{OL} = 24 mA	
I _{IH}	Input HIGH Current	54F 74F			20.0 5.0	μΑ	Max	$V_{IN} = 2.7V$	
I _{BVI}	Input HIGH Current Breakdown Test	54F 74F			100 7.0	μΑ	Max	V _{IN} = 7.0V	
I _{CEX}	Output HIGH Leakage Current	54F 74F			250 50	μΑ	Max	$V_{OUT} = V_{CC}$	
V _{ID}	Input Leakage Test	74F	4.75			٧	0.0	$I_{\text{ID}} = 1.9 \mu\text{A}$ All Other Pins Grounded	
I _{OD}	Output Leakage Circuit Current	74F			3.75	μΑ	0.0	V _{IOD} = 150 mV All Other Pins Grounded	
I _{IL}	Input LOW Current				-0.6	mA	Max	V _{IN} = 0.5V	
lozh	Output Leakage Curre	ent			50	μΑ	Max	V _{OUT} = 2.7V	
lozL	Output Leakage Current				-50	μΑ	Max	V _{OUT} = 0.5V	
los	Output Short-Circuit Current		-60		-150	mA	Max	$V_{OUT} = 0V$	
I _{ZZ}	Bus Drainage Test				500	μΑ	0.0V	V _{OUT} = 5.25V	
Іссн	Power Supply Current			9.0	15	mA	Max	V _O = HIGH	
Iccl	Power Supply Current			14.5	22	mA	Max	$V_O = LOW$	
Iccz	Power Supply Current			15	23	mA	Max	V _O = HIGH Z	

Symbol Pa		$ \begin{array}{c} {\it T_{A}} = + 25^{\circ}{\it C} \\ {\it V_{CC}} = + 5.0{\it V} \\ {\it C_{L}} = 50 {\it pF} \end{array} $			54F T _A , V _{CC} = Mil C _L = 50 pF		74F T _A , V _{CC} = Com C _L = 50 pF		Units
	Parameter								
		Min	Тур	Max	Min	Max	Min	Max]
t _{PLH} t _{PHL}	Propagation Delay I _n to Z _n	2.5 2.0	4.5 4.2	5.5 5.5	2.0 1.5	7.0 7.0	2.0 2.0	6.0 6.0	ns
t _{PLH} t _{PHL}	Propagation Delay S to Z _n	4.0 2.5	5.0 6.5	9.5 7.0	3.5 2.5	11.5 9.0	3.5 2.5	10.5 8.0	ns
t _{PZH}	Output Enable Time	2.0 2.5	5.9 5.5	6.0 7.0	2.0 2.5	8.0 9.0	2.0 2.5	7.0 8.0	- ns
t _{PHZ}	Output Disable Time	2.0 2.0	4.3 4.5	6.0 6.0	2.0 2.0	7.0 8.5	2.0 2.0	7.0 7.0	113



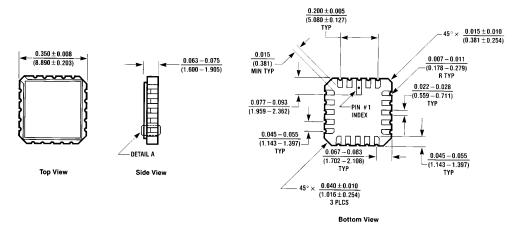
The device number is used to form part of a simplified purchasing code where the package type and temperature range are

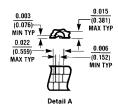


Leadless Ceramic Chip Carrier (LCC) Small Outline SOIC JEDEC

SJ = Small Outline SOIC EIAJ

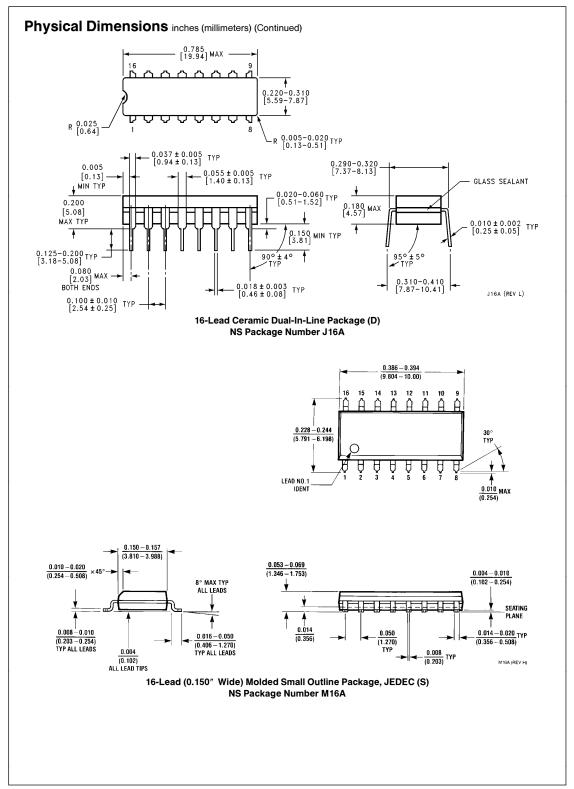
Physical Dimensions inches (millimeters)

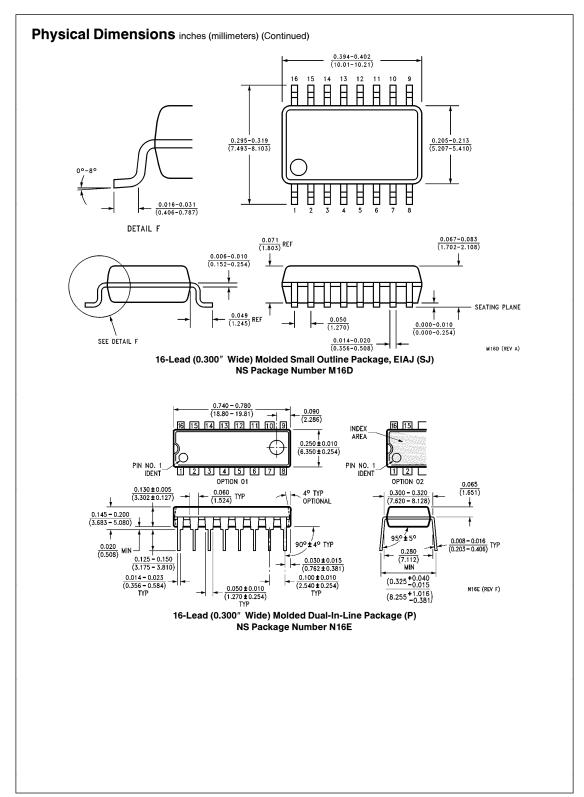




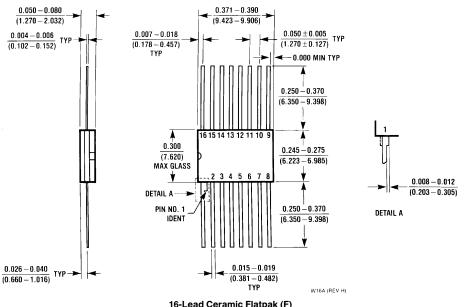
20-Lead Ceramic Leadless Chip Carrier (L) NS Package Number E20A

E20A (REV D)





Physical Dimensions inches (millimeters) (Continued)



16-Lead Ceramic Flatpak (F) NS Package Number W16A

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National Semiconductor Corporation 2900 Semiconductor Drive P.O. Box 58090 Santa Clara, CA 95052-8090 Tel: 1(800) 272-9959 TWX: (910) 339-9240 National Semiconductor GmbH Livry-Gargan-Str. 10 D-82256 Fürstenfeldbruck Germany Tel: (81-41) 35-0 Telex: 527649

Fax: (81-41) 35-1

National Semiconductor Japan Ltd. Sumitomo Chemical Engineering Center Bldg. 7F 1-7-1, Nakase, Mihama-Ku Chiba-City, Ciba Prefecture 261

National Semiconductor Hong Kong Ltd. 13th Floor, Straight Block, Ocean Centre, 5 Canton Rd. Tsimshatsui, Kowloon Hong Kong Tel: (852) 2737-1600 Fax: (852) 2736-9960 National Semiconductores Do Brazil Ltda. Rue Deputado Lacorda Franco 120-3A Sao Paulo-SP Brazil 05418-000 Tel: (55-11) 212-5066 Telex: 391-1131931 NSBR BR Fax: (55-11) 212-1181 National Semiconductor (Australia) Pty, Ltd. Building 16 Business Park Drive Monash Business Park Nottinghill, Melbourne Victoria 3168 Australia Tel: (3) 558-9999 Fax: (3) 558-9999

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